

FORM PTO-1449
(REV. 8-83)

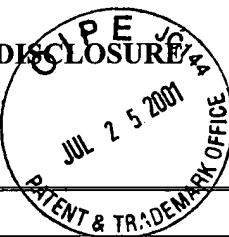
U.S. Department of Commerce
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ATTY. DOCKET:
0019696-0154

IN RE APPLICATION
NO. 09/488,742

SUPPLEMENTAL INFORMATION DISCLOSURE
STATEMENT

(Use several sheets if necessary)



APPLICANT: Otto, et al

FILING DATE: January 20, 2000

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U.S. PATENT DOCUMENTS

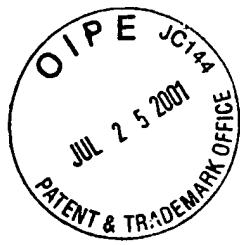
Examiner's Initials	U.S. Patent No.	Applicant	Issue Date	Class	Subclass
	5,929,000	Hahakura, et al	July 27, 1999	505	231
	5,912,607	Kalsi, et al	June 15, 1999	335	216
	5,828,291	Baumann, et al	October 27, 1998	338	328
	5,663,528	Tanaka, et al	September 2, 1997	174	125.1
	5,625,332	Kamo, et al	April 29, 1997	335	216
	5,617,280	Hara, et al	April 1, 1997	361	19
	5,304,534	Ciszek	April 19, 1994	505	434
	5,298,679	Wu, et al	March 29, 1994	174	154
	5,296,456	Shiga, et al	March 22, 1994	505	1
	5,017,553	Whitlow, et al	May 21, 1991	505	1
	4,994,633	Puhn	February 19, 1991	174	125.1
	4,700,257	Bekhaled	October 13, 1987	361	19
	4,454,380	Turowski	June 12, 1984	174	128
	4,251,328	Tunder	February 17, 1981	204	15
	4,079,187	Fillunger, et al	March 14, 1978	174	158

U.S. PATENT APPLICATIONS

Examiner's Initials:	Serial Number:	Applicant:	Filing Date:	Group:	Art Unit:

FOREIGN PATENT DOCUMENTS

Examiner's Initials	Document No.	Country	Date	Translation	
				Yes	No
	DE 197 46 975 C 1	Denmark	24 October, 1997	Abstract	
	EP 0 769 819 A1	Europe	23 April 1997	X	
	EP 0 786 783 A1	Europe	30 July 1997	X	
	JP08171822 (abstract only)	Japan	2 July 1996	X	
	JP6309955	Japan	4 November 1994	Abstract	
	WO 00/57493	PCT	28 September 2000	X	
	WO 00/10176	PCT	24 February 2000	X	
	WO 94/03955	PCT	17 February 1994	X	
	WO 98/14961	PCT	9 April 1998	X	



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SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANT: Otto, <i>et al</i>		
		FILING DATE: January 20, 2000	GROUP: 2831	
OTHER DOCUMENTS				
Examiner's Initials	Citation (Including Author, Title, Date, Pertinent Pages, Etc.)			
<i>CCR</i>	Lay, <i>et al.</i> , "Over Critical-Current Behavior of Bi-2223 Tapes" <i>IEEE Transactions on Applied Superconductivity</i> , 9 (2):1324-1327, June, 1999			
<i>CCR</i>	Hikichi, <i>et al.</i> , "Development of Ag-Mg- α Alloy Sheathed Bi2223 Multifilament Tapes" (<i>Proceedings of the 11th International Symposium of Superconductivity</i>) 915-918, Fukuoka, Japan, November, 1998			
EXAMINER	<i>CCR</i>		DATE CONSIDERED <u>3/20/03</u>	
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.				

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IDS of 7/25/01 (Paper #6) includes prior art cited in IDS of 7/3/00 (Paper #3).
Only IDS (Paper #6) will be provided with this office action
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